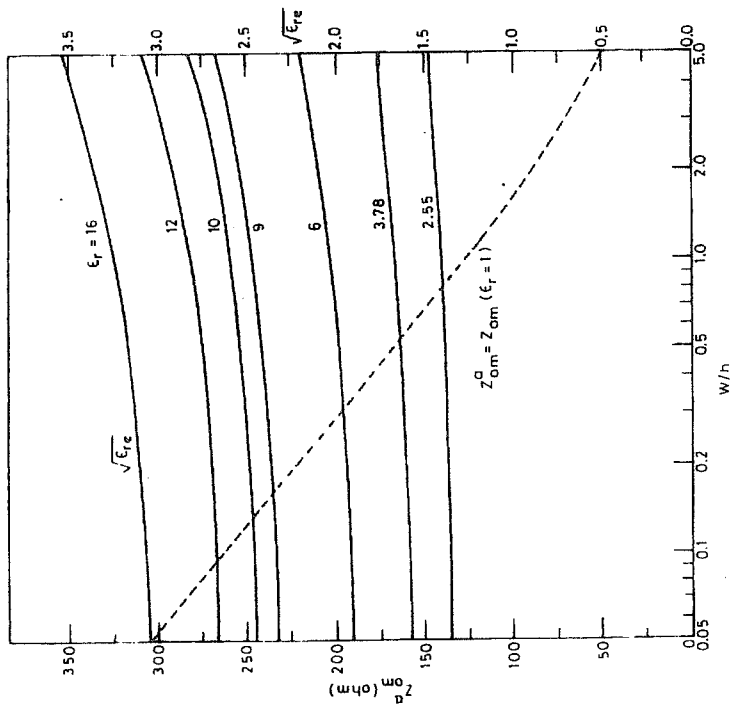


as Figure 2.8. Here ϵ_{re} is the same as ϵ_{eff} above.



Wheeler's formulas

In this figure the value of $\sqrt{\epsilon_{re}}$ is plotted as a function of W/h for various values of the substrate dielectric constant ϵ_r . The variation of characteristic impedance for air microstrip (Z_{om}^a or $\epsilon_r = 1$) is also shown by the dotted curve. The impedance for any value of ϵ_r can be obtained by dividing Z_{om}^a by the corresponding value of $\sqrt{\epsilon_{re}}$. It may be seen from Figure 2.8 that the impedance value decreases when the strip width to substrate height ratio (W/h) is increased, since an increase in W (or decrease in h) increases the line capacitance.

Since the guided wavelength in the microstrip λ_g is related to ϵ_{re} by the expression

$$\lambda_g = \frac{\lambda_0}{\sqrt{\epsilon_{re}}} \quad (2.30)$$

and 2-21. In these figures, the quantities Z_0 and ϵ_{eff} are plotted as functions of w/h ratios and ϵ_r values. The parameter range of w/h and ϵ_r is chosen such that it spans the domain of typically encountered, practical values.

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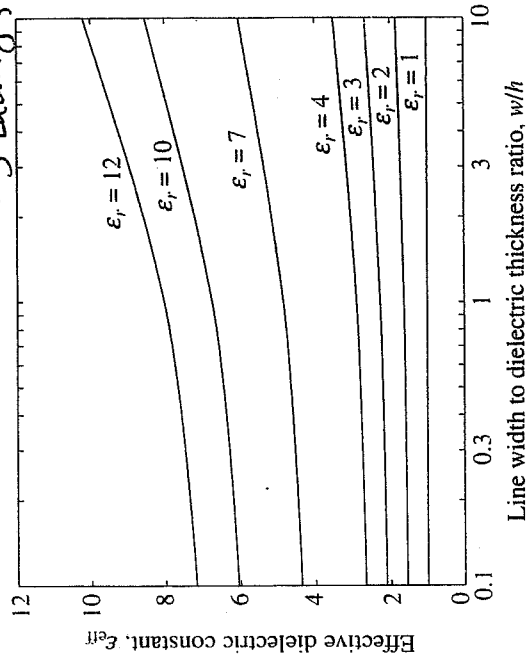


Figure 2-21 Effective dielectric constant of the microstrip line as a function of w/h for different dielectric constants.

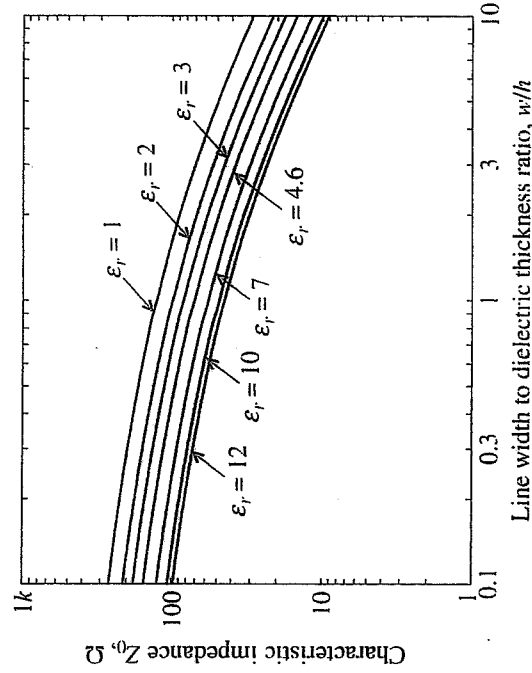


Figure 2-20 Microstrip characteristic impedance as a function of w/h